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| 著者 | Kamimura Sunao, Sasaki Yousuke, Kanaya Masaki, Tsubota Toshiki, Ohno Teruhisa |
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Improvement of selectivity for CO₂ reduction by using Cu₂ZnSnS₄ electrodes
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irradiation

Sunao Kamimura,^{1,2} Yousuke Sasaki,¹ Masaki Kanaya,¹ Toshiki Tsubota,¹ and Teruhisa
Ohno^{1,2,3*}

¹Department of Applied Chemistry, Faculty of Engineering, Kyushu Institute of Technology,
1-1 Sensuicho, Tobata, Kitakyushu 804-8550, Japan

²Research Center for Advanced Eco-fitting Technology, Kyushu Institute of Technology, 1-1
Sensuicho, Tobata, Kitakyushu 804-8550, Japan

³ACT-C, Japan Science and Technology Agency, 4-1-8 Honcho, Kawaguchi-shi, Saitama
322-0012, Japan

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*** Corresponding author: tohno@che.kyutech.ac.jp**

ABSTRACT

The CZTS electrodes modified with different *n*-type buffer layers (CdS, In₂S₃) were used as photocathodes for CO₂ reduction under visible light irradiation ($400 < \lambda < 800$ nm) in aqueous media. Compared to bare CZTS electrode, *n*-type buffer layers (CdS, In₂S₃)-modified CZTS electrode, by which *p*-*n* heterojunction between CZTS and *n*-type buffer layers is formed, afforded a significant increase in the photocurrent assigned to CO₂ reduction. In addition, a product selectivity of CO₂ reduction was improved by surface modification with *n*-type buffer layers (CdS, In₂S₃): that is, selective CO₂ reduction into CO was achieved by using CdS/CZTS electrode, while HCOOH selectivity was observed over In₂S₃/CZTS electrode. In this paper, we investigated the photoelectrochemical properties for *n*-type buffer layers (CdS, In₂S₃)-modified CZTS electrode in conjunction with the structural and optical properties, and discuss its activity for PEC CO₂ reduction.

Introduction

Carbon dioxide (CO₂) is the thermodynamically stable product of most fossil fuel combustion process and a significant contributor to the greenhouse effect. The accumulation of CO₂ in the atmosphere has an impact on climate change and could threaten the environment and eventually the worldwide economy. The conversion of CO₂ into useful products and chemicals is thus a very attractive research area. The photoelectrochemical (PEC) reduction of CO₂ to value-added products has been widely studied as a possible technique for the mitigation of atmospheric CO₂.¹⁻³ Over the past few decades, tremendous work on PEC CO₂ reduction have been performed by using semiconductor electrodes in water electrolysis as both an electron donor and a proton source,^{4,5} whose is currently called as an artificial photosynthesis. The one way of goal for an artificial photosynthesis is to directly convert CO₂ into organic fuels over *p*-type semiconductor electrodes (photocathodes) in combined with *n*-type semiconductor electrodes (photoanodes) for oxygen generation from water without applying an external voltage under sunlight illumination. To date, there have been many studies on high-efficiency photoanodes such as WO₃,^{6,7} TaON,^{8,9} Fe₂O₃,^{10,11} and BiVO₄,^{12,13} while there have been few reports on photocathodes with a high selectivity for CO₂ reduction because semiconductor electrode generally shows preferential H₂ production in the aqueous solution.

Cu₂ZnSnS₄ (CZTS) is one of the promising *p*-type semiconducting materials for PEC devices due to its ability to absorb visible light (optical band gap ca. 1.5 eV) and its relative stability in aqueous environments.¹⁴⁻¹⁶ In addition, it is made of cheap, non-toxic, earth-abundant elements and can be easily produced on a large scale. The PEC CO₂ reduction utilizing CZTS electrode was first reported in 2011 by Arai *et al.*, who carried out a study where CO₂ was reduced to formate with a high selectivity (current efficiency > ca. 80 %) by using a Ru-complex

modified CZTS electrode under visible light irradiation ($400 < \lambda < 800$ nm).¹⁷ In the absence of a Ru-complex, no formate was produced, indicating that active center of CO₂ reduction might be a Ru-complex. In addition, the activity for CO₂ reduction was also improved by the insertion of Se into CZTS electrode presumably due to an improvement of carrier mobility.

We inspired by their work, and interested in exploring the potential of *n*-type buffer layers (CdS, In₂S₃)-modified CZTS electrode for efficient PEC CO₂ reduction reaction. Since the deposition of *n*-type buffer layers (CdS, In₂S₃) over the *p*-type CZTS layer forms a depletion region at the solid-solid interface (*p*-*n* heterojunction), which could also assist in extracting photo-generated electrons from CZTS toward the *n*-type buffer layers, resulting in an enhancement of photocurrent.¹⁸⁻²⁰ Moreover, the colloidal CdS have been studied as visible light responsive photocatalysts that showed the activities for CO₂ reduction to form CO with high quantum yields from DMF involving sacrificial reagents.²¹ Li *et al.* reported that In₂S₃ exhibited visible-light activity toward photocatalytic reduction of CO₂ in the presence of water vapor into renewable CH₄.²² On the basis of these observations, enhancement of the photocurrent and improvement of selectivity for CO₂ reduction was anticipated by using *n*-type buffer layers (CdS, In₂S₃)-modified CZTS electrode. However, as far as we know, there has been no report on PEC CO₂ reduction by using of *n*-type buffer layers-modified CZTS electrode. The present research carried out from this stand point.

We fabricated CZTS electrode by sol-gel spin-coating method on molybdenum-coated glass substrate. In addition, the different *n*-type buffer layers such as CdS and In₂S₃ were deposited on CZTS electrode by chemical bath deposition (CBD) method. The bare CZTS electrode exhibited a cathodic photocurrent under visible light irradiation, and the photocurrent reached ca. -100 $\mu\text{A}/\text{cm}^2$ at 0V vs. reversible hydrogen electrode (RHE) in CO₂-saturated NaHCO₃ solution.

Moreover, the cathodic photocurrent was enhanced by deposition of *n*-type buffer layers due to efficient charge carrier separation as a result of the creation of a *p-n* heterojunction, which leading to PEC reaction with the primary product being hydrogen, carbon monoxide, and formate. In this paper, the PEC properties of CZTS electrode were investigated in conjunction with structural and optical properties, and we discuss the contributions of *n*-type buffer layers (CdS, In₂S₃) on the CO₂ reduction property.

Experimental

Preparation of Cu₂ZnSnS₄ electrode

The Cu₂ZnSnS₄ electrode was fabricated by sol-gel and spin-coating method as the following procedure.²³ The 0.4 mol/L Cu(CH₃COO)₂·H₂O (Wako, 99.0 %), 0.25 mol/L Zn(CH₃COO)₂·2H₂O (Wako, 99.9 %), 0.2 mol/L SnCl₂·2H₂O (Wako, 99.9 %) and 1.6 mol/L SC(NH₂)₂ (Wako, 98 %) were dissolved in 2-methoxyethanol (10 mL, Wako, 99.0 %) containing monoethanolamine (Sigma-Aldrich, >99.0%). The concentration of each metal ion coincides with the generally reported data for high efficiency solar cells, meanwhile excess thiourea was used to complex metal ions and alleviate the loss of sulfur during the annealing process. To avoid cracks forming in the precursor thin film during the sulfurization process, additive monoethanolamine are necessary in the precursor solution. Approximately 70 μL of the precursor solution was dropped on the Mo-coated soda lime glass (Mo/glass, size 18 mm×20 mm, GEOMATEC Co., Ltd.) and then the excess precursor solution was removed by spin-coating (3000 rpm, 30 s). The electrode was dried in air at 200 °C for 5 min on a hotplate in air. After this process had been repeated for a maximum of 5 times, the electrode was calcined in air at 560 °C for 1 h in sulfur/N₂ atmosphere. To remove the impurity phase such as Cu_{2-x}S over the

CZTS film, $(\text{NH}_4)_2\text{S}$ etching processes were performed for 6 h. Then bare CZTS electrode was obtained.

Surface modification with n-type buffer layers

The *n*-type buffer layers (CdS , In_2S_3) were deposited on the CZTS electrode by chemical bath deposition (CBD) method as the following procedure. The CZTS electrode was immersed in 0.125 mol/L $\text{Cd}(\text{CH}_3\text{COO})_2 \cdot 2\text{H}_2\text{O}$ (Wako, 98.0 %), 2.8 mol/L $\text{SC}(\text{NH}_2)_2$ (Wako, 98 %), and NH_3 aqueous solution at 65 °C for 9 min to yield CdS-modified CZTS (CdS/CZTS). For the In_2S_3 -modified CZTS ($\text{In}_2\text{S}_3/\text{CZTS}$), the CZTS electrode was immersed in an aqueous solution containing 0.025 mol/L $\text{InCl}_3 \cdot 4\text{H}_2\text{O}$ (Wako, 99.9 %), 0.1 mol/L CH_3CSNH_2 (Wako, 98.0 %), and 0.1 mol/L CH_3COOH (Wako, 99.7 %) at 65 °C for 15 min. After the CBD techniques, those electrodes were annealed at 200°C and 100 °C, respectively, and then CdS/CZTS and $\text{In}_2\text{S}_3/\text{CZTS}$ electrodes were fabricated.

Characterization

The crystalline phases were characterized by using a powder X-ray diffraction (XRD) instrument (MiniFlex II, Rigaku Co.) with $\text{CuK}\alpha$ ($\lambda=1.5418 \text{ \AA}$) radiation (cathode voltage: 30 kV, current: 15 mA). Raman spectroscopy was measured by using a JASCO NRS 5100 laser raman spectrophotometer. The absorption properties of CZTS electrode were measured using the diffuse reflection method with a UV/VIS/NIR spectrometer (V570, JASCO Co., Japan) attached to an integral sphere at room temperature. Mott-schottky analysis was carried out by using an electrochemical analyzer (604D, ALS Co.) with bare CZTS electrode, platinum electrode, Ag/AgCl electrode and 0.1 M $\text{Na}_2\text{SO}_4 + \text{NaOH}$ solution (pH=9.5) used as a working electrode, counter electrode, reference electrode and electrolyte, respectively. X-ray

photoelectron spectroscopy (XPS) measurements were performed by using a Kratos AXIS Nova spectrometer (Shimadzu Co.) with a monochromatic Al K α X-ray source. The binding energy was calibrated by taking the carbon (C) 1s peak of contaminant carbon as a reference at 284.6 eV.

Photoelectrochemical (PEC) measurement

The PEC performance of CZTS electrode was investigated in a three-electrode configuration using Ag/AgCl reference electrode and a Pt coil counter electrode. The electrolyte was CO₂-saturated 0.1 M NaHCO₃ solution. Linear sweep voltammetry and chronoamperometry measurements were carried out by using an automatic polarization system (HSV-110, Hokuto Denko Co.) under a Xe lamp equipped with an L-42 cut-off filter (SCF-50s-42L, SIGMAKOKI Co., Ltd.) and IR cut-off filter ($400 < \lambda < 800$ nm). The scan rate for the linear sweep voltammetry was 10 mV s⁻¹.

Analysis of products

The PEC CO₂ reduction was performed in a gastight three-electrode configuration cell with double compartment where CZTS electrode, Pt wire and silver-silver chloride (Ag/AgCl) electrodes were used as a working electrode, counter electrode and reference electrode, respectively. The electrolyte solution was 0.1 M NaHCO₃, which was purged with CO₂ gas for ca. 40 min prior to the start of measurement. After CO₂ bubbling, the cell was sealed and irradiated by visible light irradiation (Xe lamp, $420 \text{ nm} < \lambda < 800 \text{ nm}$) for 1 h. Evolved H₂, CO gas was detected by an on-line gas chromatograph (GC) with a thermal conductivity detector (Agilent Technology Co. MicroGC) equipped with MS-5A column. He gas was used as the carrier gas. The liquid CO₂ reduction product, formic acid (HCOOH), was detected by

using single-channel ion chromatography (ICS900, Thermo Fisher Scientific Inc.), and other products including methanol (CH_3OH), ethanol ($\text{C}_2\text{H}_5\text{OH}$), and formaldehyde (HCOH) were detected by gas chromatography (G-3500, Hitachi Co.) with a DB-WAXetr column (122-7332, Agilent Co.).

RESULTS AND DISCUSSION

3.1. Structural and optical properties of CZTS electrode

Figure 1(a) shows the XRD pattern of CZTS electrode, together with the ICDD standard file of the tetragonal phase of $\text{Cu}_2\text{ZnSnS}_4$ (JCPDS 00-026-0575). An intense peak corresponding to the bottom Mo substrate was observed at 40.02° , while the other diffraction peaks were coincided with the reference pattern corresponding to (112), (200), (220), (312), (224) planes of CZTS, indicating that CZTS crystal could be synthesized by sol-gel and spin-coating method. **Figure 1(b)** shows the Raman spectrum of CZTS electrode under 532 nm laser illumination. An intense peak centered at 333 cm^{-1} along with two weak peaks located at 288 cm^{-1} , and 368 cm^{-1} ; these signals are in agreement with those of the kesterite CZTS structure,²⁴⁻²⁶ and no other peaks were found to be binary phases such as hexagonal Cu_{2-x}S (475 cm^{-1}), Sn_2S_3 (304 cm^{-1}), ZnS (352 cm^{-1}) and cubic Cu_2SnS_3 (303 cm^{-1} and 356 cm^{-1}).²⁷ However, SnO_2 phase was observed at 663 cm^{-1} .²³ Therefore, our-fabricated CZTS electrode consists of the major phase of kesterite CZTS and the minor phases of SnO_2 . Although a slightly weak peak corresponds to hexagonal MoS_2 phase was observed at 400 cm^{-1} ,^{23,27} the MoS_2 phase plays an important role for the characteristics of CZTS electrode, as described later.

Figure 2 shows top and cross-section SEM photographs for CZTS electrode. Flat and tight structure of CZTS was observed to have good adhesion to the Mo substrate. As seen in this

photograph, a thickness of CZTS layer was estimated to be ca. 400 nm. Moreover, the MoS₂ layer was observed at an interface between CZTS layer and Mo substrate. A formation of the MoS₂ layer was inevitable via a sulfurization process of the CZTS, which may facilitate an electrical quasi-ohmic contact and improve the adhesion of CZTS to Mo back contact, but leads to high series resistance and accordingly deteriorates the device efficiency if not thin enough. In this study, we optimized the thicknesses of CZTS layer and MoS₂ layer by adjusting spin-coating and sulfurization process, respectively.

Figure 3 shows the diffuse reflectance spectrum of CZTS electrode. The CZTS is a direct energy gap material. The optical absorption of CZTS could be converted to Tauc plot, $(F(R_{\infty})hv)^n$ vs. hv , where $n = 2$ for a direct bandgap, by extending the tangential lines to the abscissa. The band gap estimated was ca. 1.5 eV, which is well-consistent with the reported ones in references.²⁸

3.2. Structural properties of buffer layers-modified CZTS electrode

Surface modifications of the CZTS electrode with *n*-type buffer layers were performed by using the CBD method. **Figure 4** shows the top and cross-section SEM photographs for *n*-type buffer layers (CdS, In₂S₃)-modified CZTS electrodes. Compared to bare CZTS, the surface morphology was appreciably changed: the surface of CdS/CZTS electrode was composed of porous grains with sizes on the order of several micrometers. In contrast, the In₂S₃/CZTS electrode surface was composed of billowing thin layer. As seen in these cross-section SEM photographs, the thicknesses of CdS and In₂S₃ buffer layers were estimated to be ca. 50 nm and ca. 60 nm, respectively. In addition, these layers would be fabricated as β -CdS and β -In₂S₃ as confirmed by Raman spectra analysis of these layers deposited on a Mo/glass (see **Fig. 5**).^{16,29-31}

Therefore, *n*-type buffer layers (CdS, In₂S₃) could be formed over CZTS electrode by CBD method.

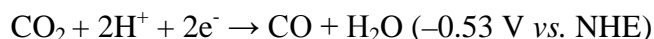
3.2. Photoelectrochemical property of CZTS electrode

Figure 6 shows the current-potential curves for bare CZTS, CdS/CZTS and In₂S₃/CZTS electrodes in 0.1 M NaHCO₃ solution purged with CO₂ gas with irradiation of visible light ($400 < \lambda < 800$ nm). The bare CZTS electrode exhibited a cathodic photocurrent in response to an irradiation of incident light, and the photocurrent density reached ca. $-160 \mu\text{A}/\text{cm}^2$ at -1.0 V vs. Ag/AgCl. The cathodic photocurrent was increased by ca. 2 times after deposition of *n*-type buffer layers (CdS, In₂S₃) because of efficient charge separation at depletion region of *p-n* heterojunction between *p*-type CZTS and *n*-type buffer layers. Moreover, deposition of Pt contributed to further enhancement of the cathodic photocurrent due to an improvement of surface reaction rate (see **Fig. S1** in ESI); however, the observed photocurrent was attributed to water reduction reaction with the primary product being hydrogen, as will be discussed later. No CO₂ reduction products was observed in Pt/CZTS, Pt/CdS/CZTS, and Pt/In₂S₃/CZTS, thereby, we studied the PEC CO₂ reduction by using bare CZTS, CdS/CZTS and In₂S₃/CZTS electrodes hereafter.

Figure 7 shows the time courses of the cathodic photocurrent from bare CZTS, CdS/CZTS and In₂S₃/CZTS electrodes in 0.1 M NaHCO₃ solution purged with CO₂ gas at -1.0 V vs. Ag/AgCl under visible light irradiation ($400 < \lambda < 800$ nm). For bare CZTS electrode, the cathodic photocurrent rapidly increased when visible light was exposed, and then the photocurrent remained constant with time. The XPS spectra for Cu 2p, Zn 2p, Sn 3d and S 2p was barely changed before and after PEC measurement (see **Fig. S2** in ESI), thereby, bare CZTS

electrode is a stable upon PEC reaction. In contrast, the cathodic photocurrent for CdS/CZTS and In₂S₃/CZTS showed a slight increase up to about 20 min and was relatively stable over the observed time course. Similar tendency has been reported by Moriya *et al.* and Septina *et al.* who indicated that CdS buffer layer in Pt/CdS/CuGaSe₂ and Pt/CdS/Cu(In,Ga)S₂ was dissolved into electrolyte upon PEC reaction due to photocorrosion of CdS, and the cathodic photocurrent in the electrodes may have increased as the CdS buffer layer became thinner.^{32,33} Indeed, we analyzed the metal cation species in the electrolyte by ICP–AES, where the Cd and In ions were detected in the electrolyte after 1 h of PEC reaction, indicating that CdS and In₂S₃ buffer layer over CZTS electrode was dissolved.

We examined PEC CO₂ reduction over bare CZTS, CdS/CZTS and In₂S₃/CZTS electrodes at –1.0 V Ag/AgCl in CO₂-saturated 0.1 M NaHCO₃ solution under visible light irradiation (400 < λ < 800 nm, 100 mW/cm²). These results are shown in **Table 1**. For bare CZTS electrode, the H₂, CO and HCOOH were detected as products and no formation of CH₄, CH₃OH and C₂H₅OH was observed. The thermodynamic potential for PEC reduction of CO₂ to CO and HCOOH in the presence of protons is generally explained by the following equation:



Here, the conduction potential of the CZTS electrode was estimated to be –1.25 V vs. RHE by Mott-Schottky analysis (see **Fig. S3** in ESI), thereby, the CO₂ reduction reactions into CO and HCOOH were thermodynamically favorable. However, the calculated faradic efficiency for H₂, CO and HCOOH was approximately 76 %, 1 % and 2 %, respectively, indicating that most of the cathodic photocurrent of bare CZTS electrode was derived from H₂ evolution. This result indicated that water reduction reaction was more preferentially caused over CZTS electrode in

the aqueous solution. In contrast, the CO evolution was increased by depositing CdS buffer layer over CZTS electrode and its faradic efficiency increased up to 7 %, implying that selectivity for CO₂ reduction was improved by using CdS/CZTS electrode. It should be noted that no CO evolution was observed when PEC measurement was performed in Ar-saturated Na₂SO₄ aqueous solution or in the dark condition, suggesting that evolved-CO gas was derived from PEC reduction of purged-CO₂ gas over CdS/CZTS electrode. In addition, Pt-modified CdS/CZTS electrode exhibited H₂ evolution with trace CO and trace HCOOH in CO₂-saturated NaHCO₃ aqueous solution under visible light irradiation. Taking into consideration that Pt shows high activity for H₂ evolution with a low overpotential, it is highly possible that water reduction reaction was more preferentially caused over Pt/CdS/CZTS electrode rather than CO₂ reduction. These results indicated that the CdS buffer layer plays an important role for selective PEC CO₂ reduction into CO. Indeed, Yanagida *et al.* proposed that the CO evolution over CdS nanoparticle was caused by adsorption of CO₂ molecule at CdS surface with sulfur vacancies through bidentate-type adsorption of CO₂, resulting in selective CO formation.²¹ Therefore, our-observation was reasonable. On the other hands, the In₂S₃/CZTS electrode generated a relatively high HCOOH by comparison with bare CZTS electrode. Its origin is currently unknown. Li *et al.* reported that In₂S₃ contributed to visible-light activity toward photocatalytic reduction of CO₂ into CH₄ without any other products.²² In addition, Ge *et al.* investigated the CO₂ adsorption over (110)-indium oxides by DFT calculation, where CO₂ molecule was adsorbed at In atom and oxygen vacancies through bidentate-type adsorption of CO₂.^{34,35} Such CO₂ reduction process is very similar to the present reaction of CdS buffer layer, which described above. On the basis of those reports, the PEC CO₂ reduction by using In₂S₃/CZTS electrode may be occurring on the In₂S₃ surfaces and thus likely show a selective CO₂ reduction into HCOOH. Thus, *n*-type buffer

layer (CdS, In₂S₃)-modified CZTS electrode showed high photocurrent response and selectivity for CO₂ reduction, which strongly dependent on a kind of buffer layers: that is, CO selectivity was improved by deposition of CdS buffer layer, while HCOOH selectivity was improved by deposition of In₂S₃ buffer layer.

Conclusions

We fabricated CZTS electrode by sol-gel and spin-coating method on a Mo/glass substrate, and performed photoelectrochemical CO₂ reduction under visible light irradiation ($\lambda > 420$ nm). The CZTS electrode exhibited a cathodic photocurrent under visible light irradiation, however its PEC reaction with the primary product being H₂ (faradaic efficiency > 76%). By depositing *n*-type buffer layer (CdS, In₂S₃) over CZTS electrode, enhancement of photocurrent response and improvement of selectivity for CO₂ reduction were achieved: that is, CO selectivity was improved by deposition of CdS buffer layer, and its faradaic efficiency was increased up to 7%. In contrast, HCOOH selectivity was improved by deposition of In₂S₃ buffer layer, and its faradaic efficiency was increased up to 5%. The improvement of selectivity for CO₂ reduction was related to a kind of *n*-type buffer layers, where the adsorption of CO₂ molecules at *n*-type buffer layers (CdS, In₂S₃) plays an important role for selective PEC CO₂ reduction. Further research is underway to test this via the deposition of surface co-catalysts that can facilitate PEC CO₂ reduction. This study could be applied to improve the selectivity for CO₂ reduction by using other Cu-chalcogenide photocathode.

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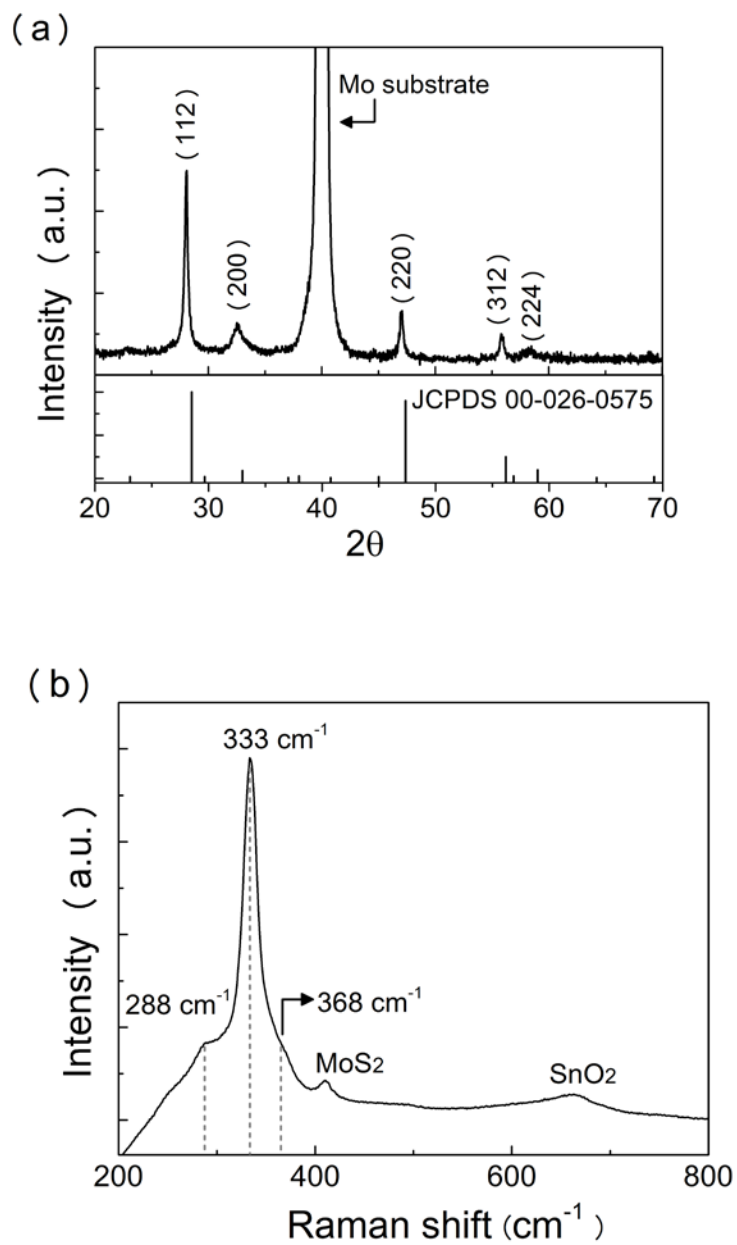


Figure 1. (a) XRD pattern of CZTS electrode, together with that of reference pattern. (b) Raman spectrum of CZTS electrode under 532 laser illumination.

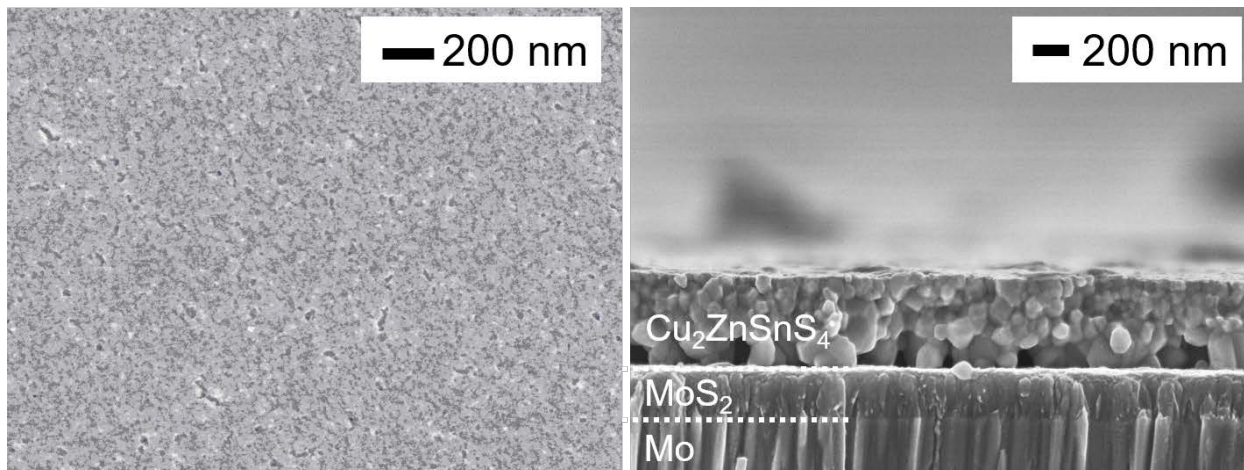


Figure 2. Top (left) and cross-sectional (right) SEM photographs of CZTS electrode.

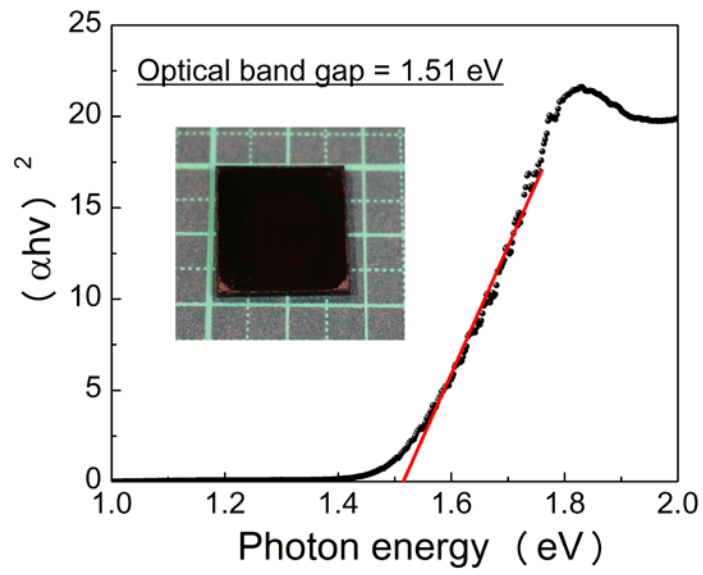


Figure 3. Tauc plot for CZTS electrode. Inset figure shows a picture for our-fabricated CZTS electrode.

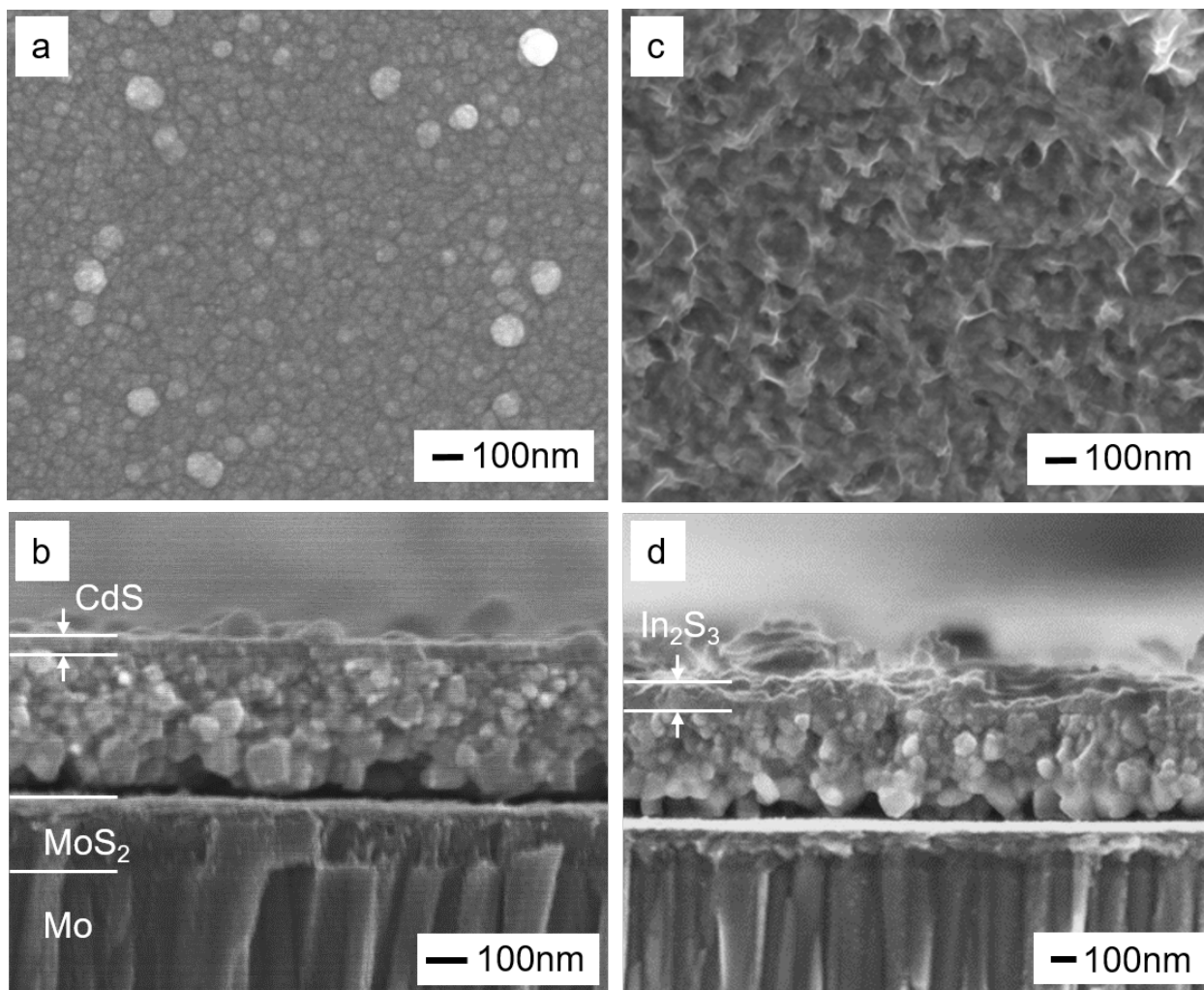


Figure 4. Top and cross-sectional SEM photographs for (a), (b) CdS/CZTS electrode, (c), (d) In₂S₃/CZTS electrode.

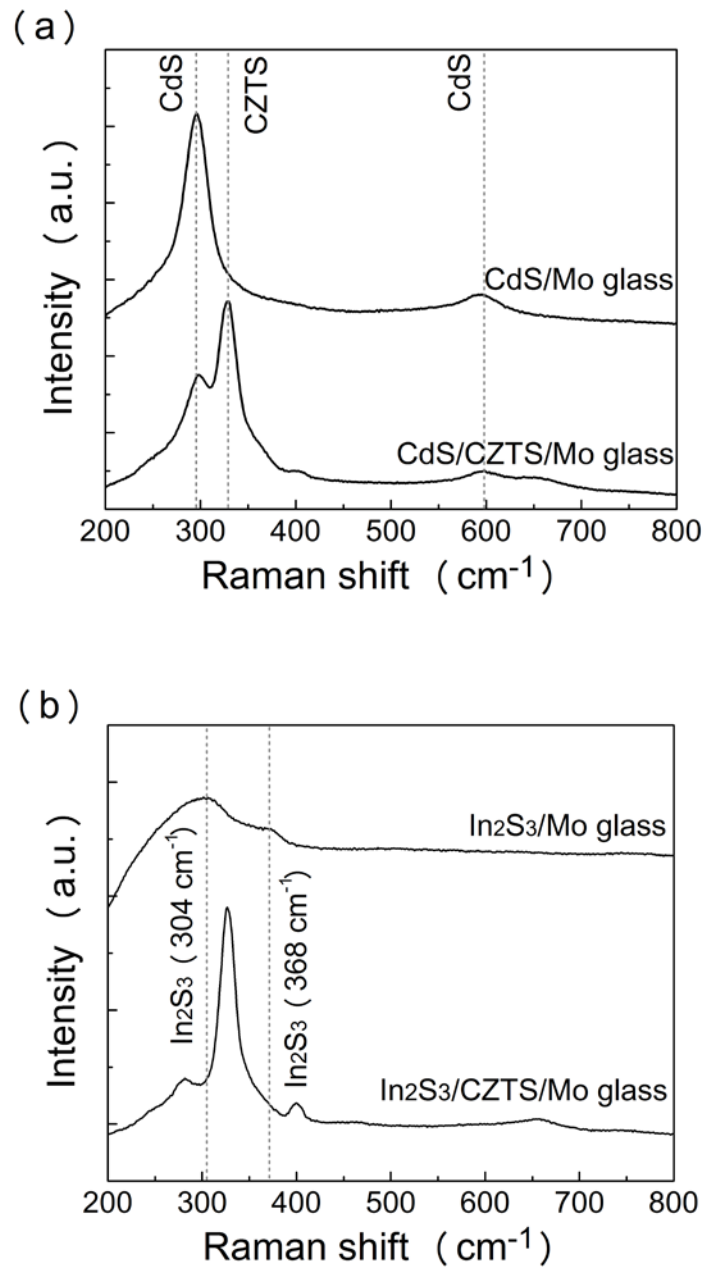


Figure 5. Raman spectra for (a) CdS/Mo glass and CdS/CZTS/Mo glass, (b) $\text{In}_2\text{S}_3/\text{Mo glass}$ and $\text{In}_2\text{S}_3/\text{CZTS}/\text{Mo glass}$.

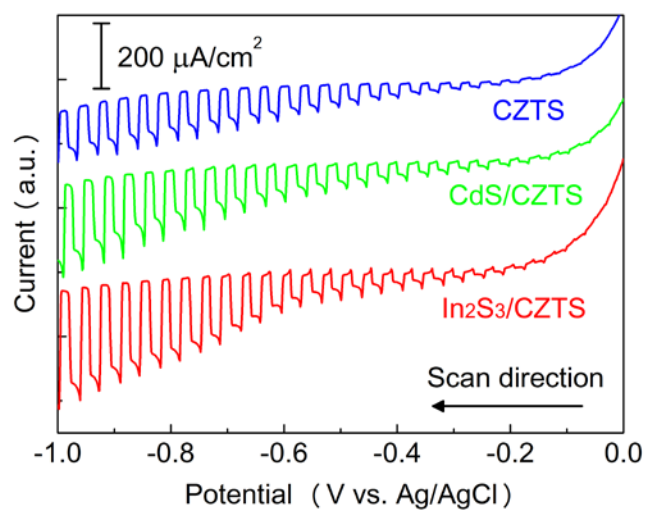


Figure 6. Current–potential curves in 0.1 M NaHCO₃ solution under chopped visible light irradiation ($400 < \lambda < 800$ nm, 100 mW/cm^2) for CZTS, CdS/CZTS and In₂S₃/CZTS electrode.

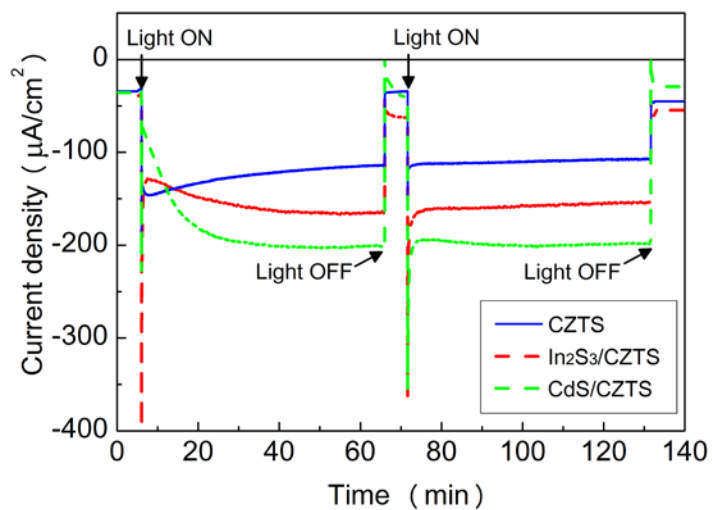


Figure 7. Time course for the photocurrent of CZTS, CdS/CZTS and In₂S₃/CZTS electrode in aqueous 0.1 M NaHCO₃ solution at -1.0 V vs. Ag/AgCl under visible light irradiation ($400 < \lambda < 800$ nm, 100 mW/cm²).

Table. 1 Photoelectrochemical CO₂ reduction by using CZTS electrode.*

| Entry | Sample | Condition | Coulomb (C) | Products | | | | | | Total (%) |
|-------|---|-------------------------------------|-------------|-----------------------|------------------------------|-----------|------------------|--------------|---------------------|-----------|
| | | Purge Gas-Electrolyte | | H ₂ (μmol) | F. E. for H ₂ (%) | CO (nmol) | F. E. for CO (%) | HCOOH (nmol) | F. E. for HCOOH (%) | |
| 1 | CZTS | CO ₂ -NaHCO ₃ | 0.8 | 3.0 | 72 | 59 | 1.4 | 110 | 2.7 | 76.1 |
| 2 | CZTS | Ar-Na ₂ SO ₄ | 0.4 | 1.3 | 63 | n.d. | 0 | n.d. | 0 | 63.0 |
| 3 | CdS/CZTS | CO ₂ -NaHCO ₃ | 1.2 | 5.0 | 80 | 435 | 7.0 | 75 | 1.2 | 88.2 |
| 4 | In ₂ S ₃ /CZTS | CO ₂ -NaHCO ₃ | 1.1 | 4.1 | 72 | 194 | 3.4 | 266 | 4.7 | 80.1 |
| 5 | Pt/CdS/CZTS | CO ₂ -NaHCO ₃ | 6.9 | 20 | 56 | trace | - | trace | - | 56.0 |
| 6 | Pt/In ₂ S ₃ /CZTS | CO ₂ -NaHCO ₃ | 5.8 | 23 | 77 | trace | - | trace | - | 77.0 |

*Visible light irradiation ($400 < \lambda < 800$ nm, 100 mW/cm²) for 1 h. Applied potential was -1.0 V 381 vs. Ag/AgCl.